

DC-13~GHz 0.5 dB LSB 6-Bit Digital Attenuator

ADH424S

1.0 SCOPE

This specification documents the detail requirements for an internally defined equivalent flow per MIL-PRF-38535 Level V except as modified herein.

The manufacturing flow described in the RF & MICROWAVE STANDARD SPACE LEVEL PRODUCTS PROGRAM brochure is to be considered a part of this specification.

This data specifically details the space grade version of this product. A more detailed operational description and a complete data sheet for commercial product grades can be found at http://www.analog.com/HMC424.

2.0 Part Number

The complete part number(s) of this specification follows:

<u>Specific Part Number</u> <u>Description</u>

ADH424-701LH5 DC – 13 GHz, GaAs MMIC Hermetic 0.5 dB LSB 6-Bit Digital Attenuator

3.0 Case Outline

The case outline is as follows:

| Outline Letter | Descriptive Designator | <u>Terminals</u> | <u>Lead Finish</u> | Package style |
|----------------|------------------------|------------------|--------------------|----------------------------|
| Χ | E-12-5 | 12 Lead | Gold | Ceramic Hermetic SMT (LH5) |

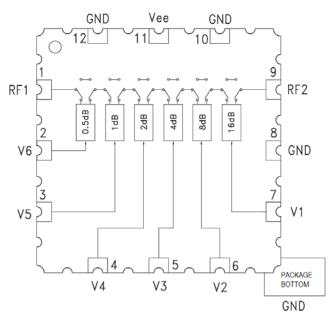


Figure 1 – Functional Block Diagram 1/ 1/ Package top view

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| | Package: X | | | | | |
|-------------------|--------------------|----------------|--|---------------------|--|--|
| Pin Number | Terminal Symbol | Pin Type | Pin Description | Interface Schematic | | |
| 1 | RF1 | RF I/O | This pin is DC coupled and matched to 50 Ω . Blocking capacitors are required if RF line potential is not equal to 0 V. | | | |
| 2 - 7 | V6 – V1 | Digital Inputs | See Truth Table (Table III) and Control Voltages Table (Table IV) | 100K Vee | | |
| 8, 10, 12 | GND | Power | Ground | O GND | | |
| 9 | RF2 | RF I/O | This pin is DC coupled and matched to 50 Ω . Blocking capacitors are required if RF line potential is not equal to 0 V. | | | |
| 11 | Vee | Power | Supply Voltage | | | |
| Package Bottom | GND | Power | Ground <u>1</u> / | O GND | | |
| Package Lid | GND | Power | Ground <u>2</u> / | O GND | | |

Figure 2 - Terminal Connections

 $[\]underline{1}/$ Package bottom must be connected RF/DC ground. $\underline{2}/$ Package lid is internally connected to RF/DC ground.

4.0 Specifications

| 4.1. <u>Absolute Maximum Ratings 1</u> / | |
|--|--|
| Control Voltage (VCTL on V1 to V6) | Vee - 0.5 Vdc |
| Bias Voltage (Vee) | 7 Vdc |
| RF Input Power (0.5 – 13 GHz) | +25 dBm |
| Storage Temperature Range | 65 °C to +150 °C |
| Junction Temperature Maximum (TJ) | 150 °C |
| Thermal Resistance, Junction-to-Case (θ _{JC}) | 344 °C/W |
| ESD Sensitivity (HBM) | Class 0, passed 50V |
| | |
| 4.2 | |
| Supply Voltage Range (Vee) | 5 Vdc ± 10 % |
| A 1: (O :: T :: D :: T) | 40.00 to .05.00 |
| Ambient Operating Temperature Range (T _A) | 40 °C to +85 °C |
| | |
| 4.3 | |
| 4.3 | Nominal Operating Performance |
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| 4.3. Characteristics 2/ Return Loss (RF1 & RF2, All Attenuation States, DC – 13 GH Input Power 0.1 dB Compression (1 – 13 GHz) | Nominal Operating Performance Hz) 12 dBm 22 dBm 46 dBm 32 dBm |
| 4.3. Characteristics 2/ Return Loss (RF1 & RF2, All Attenuation States, DC – 13 GH Input Power 0.1 dB Compression (1 – 13 GHz) | Nominal Operating Performance Hz) 12 dBm 22 dBm 46 dBm 32 dBm 30 ns |

^{1/} Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions outside of those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

2/ All typical specifications are at T_A = 25 °C, unless otherwise noted.

3/ f₁ power = f₂ power = 0 dBm, Fixed Delta F = 1 MHz

TABLE I – ELECTRICAL PERFORMANCE CHARACTERISTICS

| Parameter | | Conditions 1/2/ | Group A | Limits | | | |
|---|--------|-------------------------------|--|---|-----|-------|--|
| See notes at end of table | Symbol | Unless otherwise specified | Subgroups | Min | Max | Units | |
| | | 4 GHz | 4, 5, 6 | | 3.2 | dB | |
| Incombine Loca 3/ | | 8 GHz | 4, 5, 6 | | 3.8 | dB | |
| Insertion Loss <u>3</u> / | IL | 12 GHz | 4 | | 4.7 | dB | |
| | | | 5, 6 | | 4.8 | dB | |
| Attenuation Accuracy: 0.5–16.5 dB States <u>3</u> / | | 4.611 | 4 | \pm (0.4 + 4% of Atten. Setting) Max \pm (0.5 + 4% of Atten. Setting) Max | | - dB | |
| Attenuation Accuracy. 0.5–10.5 db States <u>5</u> / | | 4 GHz, AA 8 GHz, 12 GHz | 5, 6 | | | | |
| Attornation Assumption 17.0 21.5 dD Ctates 2/ | | | $\Lambda = \frac{1}{2} + $ | ± (0.5 + 5% of Atten. Setting) Max | | | |
| Attenuation Accuracy: 17.0 – 31.5 dB States <u>3/</u> | | 12 0112 | 5, 6 | ± (0.6 + 5% of Atten. Setting) Max | | | |
| Bias Current | lee | | 1, 2, 3 | 5 | | mA | |

TABLE I Notes:

TABLE IIA – ELECTRICAL TEST REQUIREMENTS:

| Test Requirements | Subgroups (in accordance with MIL-PRF-38535, Table III) |
|---|---|
| Interim Electrical Parameters | 1 |
| Final Electrical Parameters | 1, 4 <u>1</u> / <u>2</u> / |
| Group A Test Requirements | 1, 2, 3, 4, 5, 6 |
| Group C end-point electrical parameters | 1, 4 <u>2</u> / |
| Group D end-point electrical parameters | 1, 4 |

Table IIA Notes:

TABLE IIB - LIFE TEST/BURN-IN DELTA LIMITS 1/2/

| Parameter | Test Conditions | Symbol | Delta | Units |
|----------------|-----------------|--------|-------|-------|
| Bias Current | Per Table I | lee | ± 10 | % |
| Insertion Loss | | IL | ± 1 | dB |

Table IIB Notes:

 $[\]underline{1}/T_A$ nom = 25 °C, T_A max = 85 °C and T_A min = -40 °C, 50 ohm system, unless otherwise noted.

 $[\]underline{2}$ / Vee = -5 V, VCTL Low = 0 V, VCTL High = -5 V.

^{3/}RF Input Power = -15 dBm.

 $[\]underline{\text{1}}/\text{ PDA}$ applies to Table I subgroup 1 and Table IIB delta parameters.

^{2/} See Table IIB for delta parameters.

^{1/240} hour burn in and 1000 hour life test (Group C) end point electrical parameters. 2/ Deltas are performed at $T_A = +25$ °C only.

TABLE III – TRUTH TABLE

| | Control Voltage Input | | | | | Attenuation State | |
|-------|-----------------------|------|------|------|--------|-------------------|--|
| V1 | V2 | V3 | V4 | V5 | V6 | RF1 – RF2 | |
| 16 dB | 8 dB | 4 dB | 2 dB | 1 dB | 0.5 dB | KFI-KFZ | |
| Low | Low | Low | Low | Low | Low | Reference IL | |
| Low | Low | Low | Low | Low | High | 0.5 dB | |
| Low | Low | Low | Low | High | Low | 1 dB | |
| Low | Low | Low | High | Low | Low | 2 dB | |
| Low | Low | High | Low | Low | Low | 4 dB | |
| Low | High | Low | Low | Low | Low | 8 dB | |
| High | Low | Low | Low | Low | Low | 16 dB | |
| High | High | High | High | High | High | 31.5 dB | |

Table III Note:

TABLE IV - CONTROL VOLTAGES

| State | Bias Condition |
|-------|-----------------------------------|
| Low | 0 V to -3 V @ 35 μA Typical |
| High | Vee to Vee + 0.8 V @ 5 μA Typical |

^{1/} Any combination of the above states will provide an attenuation approximately equal to the sum of the bits selected.

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5.0 Burn-In Life Test, and Radiation

5.1. <u>Burn-In Test Circuit</u>, <u>Life Test Circuit</u> HTRB is not applicable for this drawing.

5.2. Test Conditions and Circuit

The test conditions and circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 test condition B of MIL-STD-883.

6.0 MIL-PRF-38535 QMLV Exceptions

The manufacturing flow described in the RF & MICROWAVE STANDARD SPACE LEVEL PRODUCTS PROGRAM is to be considered a part of this specification. The brochure describes standard QMLV exceptions for Aerospace products run at the ADI Chelmsford, MA facility.

6.1. Wafer Fabrication

Foundry information is available upon request.

6.2. Group D

Group D-5 Salt Atmosphere testing is not performed.

7.0 Application Notes

The circuit board used in the final application should be generated with proper RF circuit design techniques. Signal lines at the RF ports should have 50 Ohm impedance. Also, the package ground leads, and package bottom should be connected directly to the ground plane. The recommended circuit board material is Rogers 4350.

8.0 Package Outline Dimensions

The LH5 package and outline dimensions can be found at http://www.analog.com or upon request.

ORDERING GUIDE

| Model | Temperature Range | Package Description | Package Option |
|---------------|-------------------|------------------------------|----------------|
| ADH424-701LH5 | −40 °C to +85 °C | 12 Lead Ceramic Hermetic SMT | LH5 (E-12-5) |

| | Revision History | | | | | |
|-----|-----------------------------|-----------|--|--|--|--|
| Rev | Description of Change | Date | | | | |
| Α | Initial Release | 4/20/2021 | | | | |
| В | Update internal description | 9/22/2021 | | | | |
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